

Notice of References Cited	Application/Control No. 10/719,319	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Patricia L. Hailey	Art Unit 1755	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-3,988,259	10-1976	Ray, Gardner C.	502/25
*	C	US-2004/0225165	11-2004	Allison et al.	568/910.5
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	K	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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Patricia L. Hailey